

**Search Notes**

Application/Control No.

10/767,446

Examiner

Chuck Huynh

Applicant(s)/Patent under  
Reexamination

BARCLAY ET AL.

Art Unit

2683

**SEARCHED**

Class	Subclass	Date	Examiner
455	428	9/30/2005	CH
379	208.01	9/30/2005	CH
370	260	9/30/2005	CH
370	455	9/30/2005	CH
370	349	9/30/2005	CH
455	555	9/30/2005	CH
455	517	9/30/2005	CH
370	335	9/30/2005	CH
455	418	9/30/2005	CH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IDS / Class/Subclass/ combined text	9/30/2005	CH